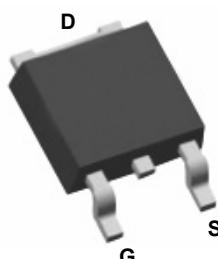
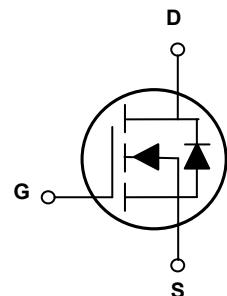


Main Product Characteristics

$V_{(BR)DSS}$	100V
$R_{DS(ON)}$	55mΩ
I_D	25A



TO-252 (DPAK)



Schematic Diagram

Features and Benefits

- Advanced MOSFET process technology
- Ideal for high efficiency switched mode power supplies
- Low on-resistance with low gate charge
- Fast switching and reverse body recovery



Description

The SSFD0904 utilizes the latest techniques to achieve high cell density and low on-resistance. These features make this device extremely efficient and reliable for use in high efficiency switch mode power supply and a wide variety of other applications.

Absolute Maximum Ratings ($T_C=25^\circ C$ unless otherwise specified)

Parameter	Symbol	Rating	Units
Drain-Source Voltage	V_{DS}	100	V
Gate-Source Voltage	V_{GS}	± 20	V
Drain Current – Continuous ($T_C=25^\circ C$)	I_D	25	A
Drain Current – Continuous ($T_C=100^\circ C$)		15	A
Drain Current – Pulsed ¹	I_{DM}	100	A
Power Dissipation ($T_C=25^\circ C$)	P_D	73.5	W
Power Dissipation – Derate above $25^\circ C$		0.58	W/ $^\circ C$
Storage Temperature Range	T_{STG}	-50 to +150	$^\circ C$
Operating Junction Temperature Range	T_J	-50 to +150	$^\circ C$

Thermal Characteristics

Parameter	Symbol	Typ.	Max.	Unit
Thermal Resistance Junction to Ambient	$R_{\theta JA}$	---	62	$^\circ C/W$
Thermal Resistance Junction to Case	$R_{\theta JC}$	---	1.7	$^\circ C/W$

Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	$\text{V}_{\text{GS}}=0\text{V}$, $\text{I}_D=250\mu\text{A}$	100	---	---	V
BV_{DSS} Temperature Coefficient	$\Delta \text{BV}_{\text{DSS}}/\Delta T_J$	Reference to 25°C , $\text{I}_D=1\text{mA}$	---	0.05	---	$\text{V}/^\circ\text{C}$
Drain-Source Leakage Current	I_{DSS}	$\text{V}_{\text{DS}}=100\text{V}$, $\text{V}_{\text{GS}}=0\text{V}$, $T_J=25^\circ\text{C}$	---	---	1	μA
		$\text{V}_{\text{DS}}=80\text{V}$, $\text{V}_{\text{GS}}=0\text{V}$, $T_J=125^\circ\text{C}$	---	---	10	μA
Gate-Source Leakage Current	I_{GSS}	$\text{V}_{\text{GS}}=\pm 20\text{V}$, $\text{V}_{\text{DS}}=0\text{V}$	---	---	± 100	nA
On Characteristics						
Static Drain-Source On-Resistance	$\text{R}_{\text{DS(ON)}}$	$\text{V}_{\text{GS}}=10\text{V}$, $\text{I}_D=10\text{A}$	---	45	55	$\text{m}\Omega$
		$\text{V}_{\text{GS}}=4.5\text{V}$, $\text{I}_D=5\text{A}$	---	50	60	$\text{m}\Omega$
Gate Threshold Voltage	$\text{V}_{\text{GS(th)}}$	$\text{V}_{\text{GS}}=\text{V}_{\text{DS}}$, $\text{I}_D=250\mu\text{A}$	1.2	1.6	2.5	V
$\text{V}_{\text{GS(th)}}$ Temperature Coefficient	$\Delta \text{V}_{\text{GS(th)}}$		---	-5	---	$\text{mV}/^\circ\text{C}$
Forward Transconductance	g_{fs}	$\text{V}_{\text{DS}}=10\text{V}$, $\text{I}_D=3\text{A}$	---	8.7	---	S
Dynamic and Switching Characteristics						
Total Gate Charge ^{2, 3}	Q_{g}	$\text{V}_{\text{DS}}=50\text{V}$, $\text{V}_{\text{GS}}=10\text{V}$, $\text{I}_D=5\text{A}$	---	46	80	
Gate-Source Charge ^{2, 3}	Q_{gs}		---	4.5	9	nC
Gate-Drain Charge ^{2, 3}	Q_{gd}		---	12	20	
Turn-On Delay Time ^{2, 3}	$\text{T}_{\text{d(on)}}$	$\text{V}_{\text{DD}}=30\text{V}$, $\text{V}_{\text{GS}}=10\text{V}$, $\text{R}_{\text{G}}=3.3\Omega$ $\text{I}_D=1\text{A}$	---	6.8	12	
Rise Time ^{2, 3}	T_r		---	21	40	
Turn-Off Delay Time ^{2, 3}	$\text{T}_{\text{d(off)}}$		---	32	60	nS
Fall Time ^{2, 3}	T_f		---	8.2	16	
Input Capacitance	C_{iss}	$\text{V}_{\text{DS}}=25\text{V}$, $\text{V}_{\text{GS}}=0\text{V}$, $\text{F}=1\text{MHz}$	---	2860	4200	
Output Capacitance	C_{oss}		---	120	180	pF
Reverse Transfer Capacitance	C_{rss}		---	70	105	
Gate Resistance	R_{g}	$\text{V}_{\text{GS}}=0\text{V}$, $\text{V}_{\text{DS}}=0\text{V}$, $\text{F}=1\text{MHz}$	---	1.2	2.4	Ω
Drain-Source Diode Characteristics and Maximum Ratings						
Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Continuous Source Current	I_{s}	$\text{V}_{\text{G}}=\text{V}_{\text{D}}=0\text{V}$, Force Current	---	---	25	A
Pulsed Source Current	I_{SM}		---	---	50	A
Diode Forward Voltage	V_{SD}	$\text{V}_{\text{GS}}=0\text{V}$, $\text{I}_{\text{s}}=1\text{A}$, $T_J=25^\circ\text{C}$	---	---	1	V
Reverse Recovery Time ²	t_{rr}	$\text{I}_{\text{s}}=1\text{A}$, $d\text{I}/dt=100\text{A}/\mu\text{s}$, $T_J=25^\circ\text{C}$	---	---	---	nS
Reverse Recovery Charge ²	Q_{rr}		---	---	---	nC

Note:

1. Repetitive Rating: Pulsed width limited by maximum junction temperature.
2. The data tested by pulsed, pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$.
3. Essentially independent of operating temperature.

Typical Electrical and Thermal Characteristic Curves

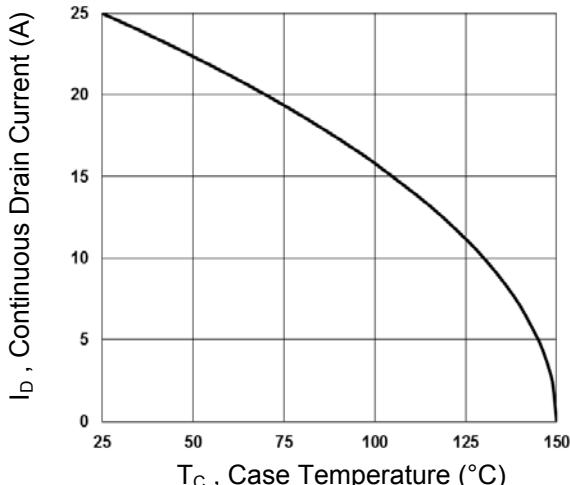


Fig.1 Continuous Drain Current vs. T_c

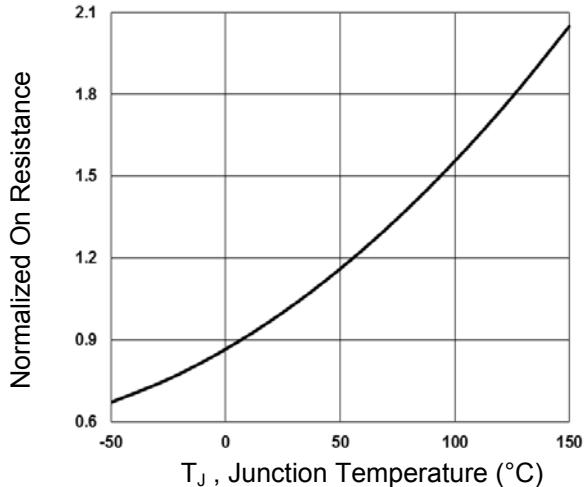


Fig.2 Normalized R_{DS(ON)} vs. T_J

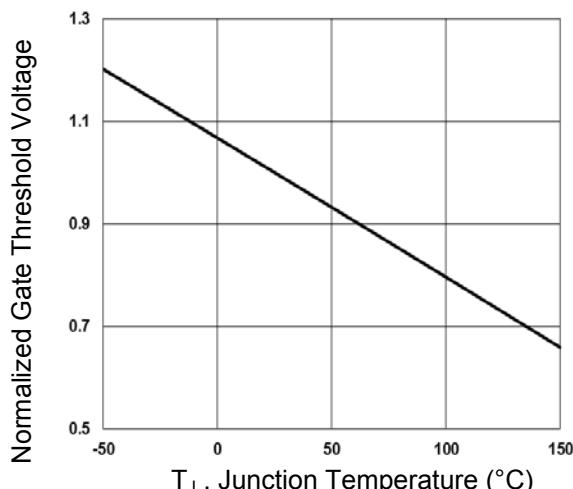


Fig.3 Normalized V_{th} vs. T_J

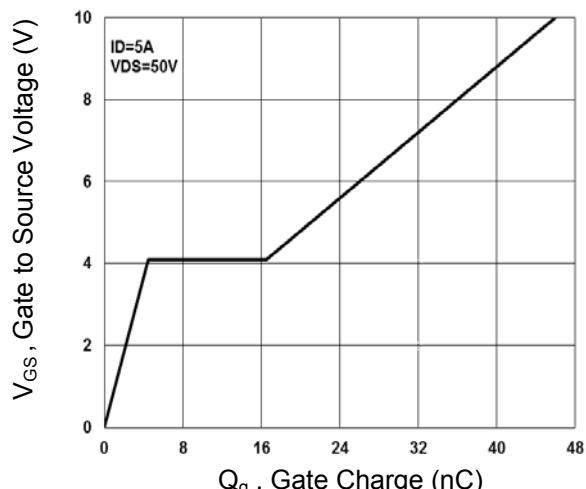


Fig.4 Gate Charge Characteristics

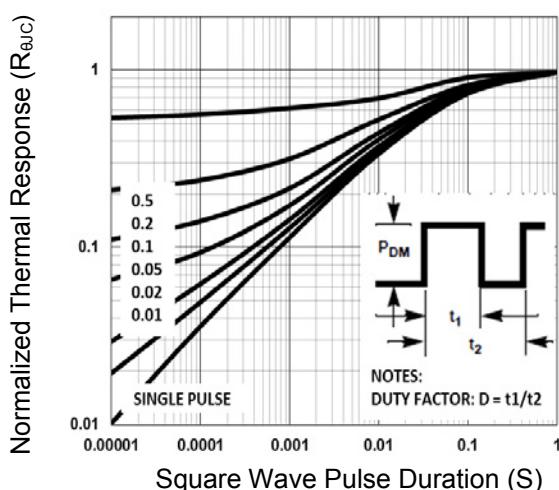


Fig.5 Normalized Transient Impedance

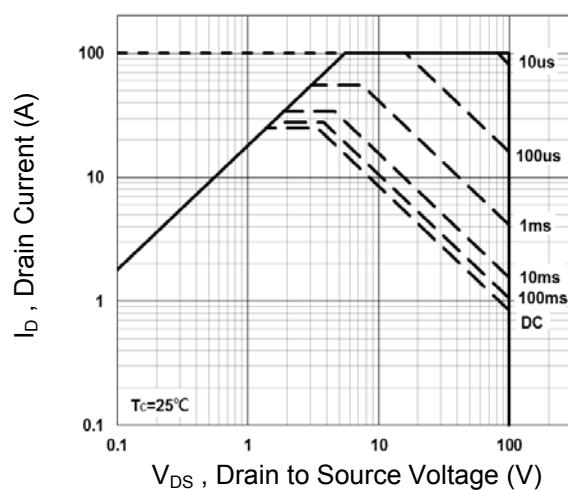


Fig.6 Maximum Safe Operation Area

Typical Electrical and Thermal Characteristic Curves

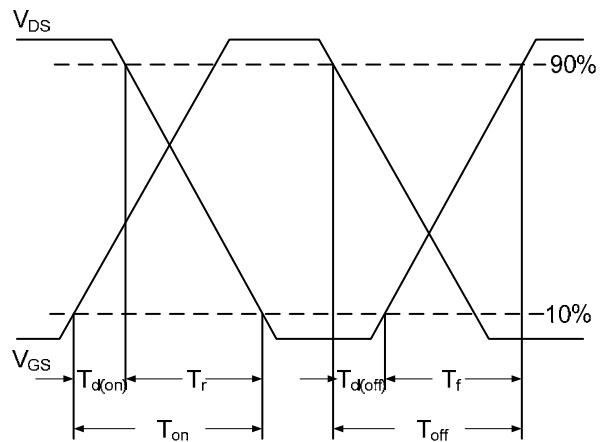


Fig.7 Switching Time Waveform

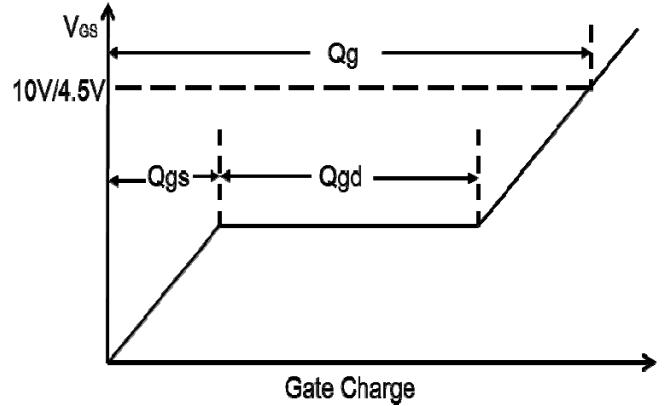
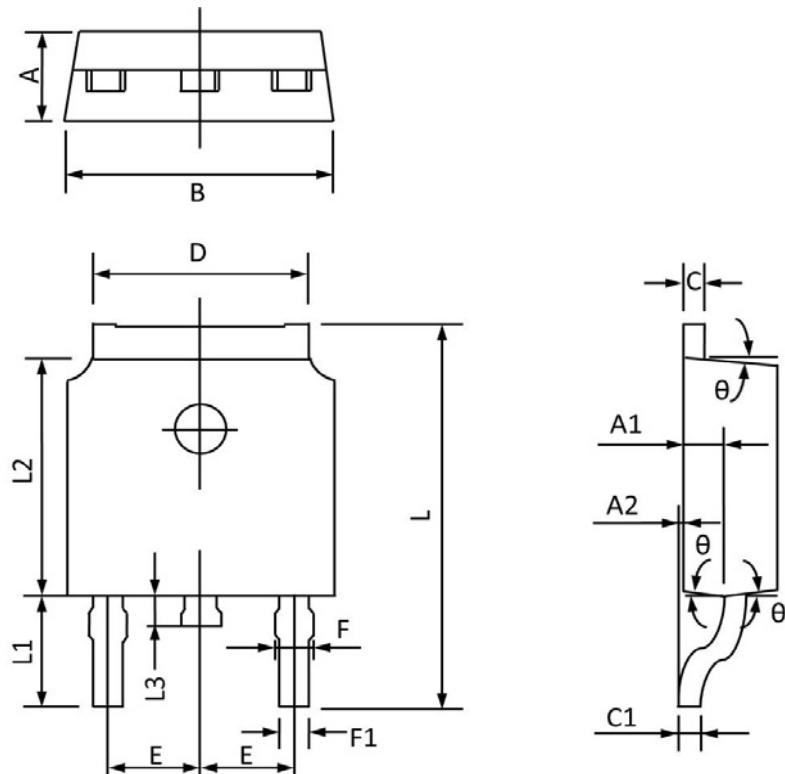


Fig.8 Gate Charge Waveform

Package Outline Dimensions

TO-252 (DPAK)



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	2.20	2.40	0.087	0.094
A1	0.91	1.11	0.036	0.044
A2	0.00	0.15	0.000	0.006
B	6.50	6.70	0.256	0.264
C	0.46	0.580	0.018	0.230
C1	0.46	0.580	0.018	0.030
D	5.10	5.46	0.201	0.215
E	2.186	2.386	0.086	0.094
F	0.74	0.94	0.029	0.037
F1	0.660	0.860	0.026	0.034
L	9.80	10.40	0.386	0.409
L1	2.9REF		0.114REF	
L2	6.00	6.20	0.236	0.244
L3	0.60	1.00	0.024	0.039
θ	3°	9 °	°3	9 °